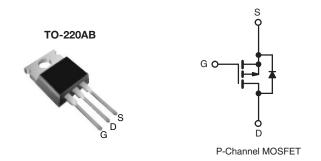


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	- 10	- 100			
R _{DS(on)} (Ω)	V _{GS} = - 10 V	0.20			
Q _g (Max.) (nC)	61	61			
Q _{gs} (nC)	14	14			
Q _{gd} (nC)	29	29			
Configuration	Sing	Single			



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- 175 °C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRF9540PbF		
Lead (FD)-life	SiHF9540-E3		
SnPb	IRF9540		
SIFD	SiHF9540		

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V_{DS}	- 100	V	
Gate-Source Voltage	V_{GS}	± 20			
Continuous Drain Current	V_{GS} at - 10 V $T_{C} = 25 ^{\circ}C$ $T_{C} = 100 ^{\circ}C$		- 19	А	
Continuous Drain Current	$T_{\rm C} = 100 ^{\circ}{\rm C}$	I _D	- 13		
Pulsed Drain Current ^a	I_{DM}	- 72			
Linear Derating Factor			1.0	W/°C	
Single Pulse Avalanche Energy ^b		E _{AS}	640	mJ	
Repetitive Avalanche Current ^a		I _{AR}	- 19	Α	
Repetitive Avalanche Energy ^a	E _{AR}	15	mJ		
Maximum Power Dissipation	T _C = 25 °C	P_{D}	150	W	
Peak Diode Recovery dV/dtc	dV/dt	- 5.5	V/ns		
Operating Junction and Storage Temperature Range		T _J , T _{stq}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d	7	
Mounting Torque	0.00 140		10	lbf ⋅ in	
	6-32 or M3 screw		1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = -25$ V, starting $T_J = 25$ °C, L = 2.7 mH, $R_g = 25$ Ω , $I_{AS} = -19$ A (see fig. 12).
- c. $I_{SD} \le$ 19 A, $dI/dt \le$ 200 A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 1\bar{7}5$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	62	
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static						l.	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$	V, I _D = - 250 μA	- 100	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I _D = - 1 mA	-	- 0.087	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	_{GS} , I _D = - 250 μA	- 2.0	-	- 4.0	V
Gate-Source Leakage	I _{GSS}	Vo	_{GS} = ± 20 V	-	-	± 100	nA
Zova Cata Valtaga Duain Current		V _{DS} = - 100 V, V _{GS} = 0 V		-	-	- 100	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 80 V,	V _{GS} = 0 V, T _J = 150 °C	-	-	- 500	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 11 A ^b	-	-	0.20	Ω
Forward Transconductance	9 _{fs}	V _{DS} = -	50 V, I _D = - 11 A ^b	6.2	-	-	S
Dynamic							
Input Capacitance	C _{iss}	,	$V_{GS} = 0 \text{ V},$	-	1400	-	
Output Capacitance	C _{oss}	$V_{DS} = -25 \text{ V},$		-	590	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1.0	MHz, see fig. 5	-	140	-	
Total Gate Charge	Qg			-	-	61	
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V	$V_{GS} = -10 \text{ V}$ $I_D = -19 \text{ A}, V_{DS} = -80 \text{ V},$ see fig. 6 and 13 ^b		-	14	nC
Gate-Drain Charge	Q _{gd}	1			-	29	
Turn-On Delay Time	t _{d(on)}			-	16	-	
Rise Time	t _r	$V_{DD} = -50 \text{ V}, I_D = -19 \text{ A},$ $R_g = 9.1 \Omega, R_D = 2.4 \Omega, \text{ see fig. } 10^b$		-	73	-	ns
Turn-Off Delay Time	t _{d(off)}			-	34	-	
Fall Time	t _f			-	57	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	-11
Internal Source Inductance	L _S			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 19	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	- 72	
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = - 19 A, V _{GS} = 0 V ^b		-	-	- 5.0	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = - 19 A, dl/dt = 100 A/μs ^b		-	130	260	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.35	0.70	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)			<u> </u>		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300 \,\mu\text{s}$; duty cycle $\leq 2 \,\%$.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

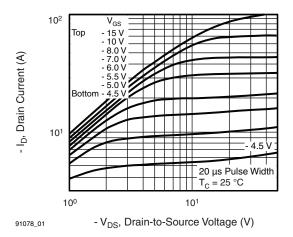


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

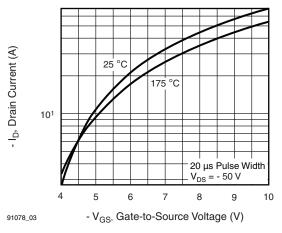


Fig. 3 - Typical Transfer Characteristics

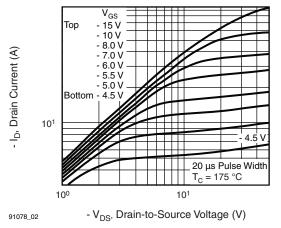


Fig. 2 - Typical Output Characteristics, T_C = 175 $^{\circ}$ C

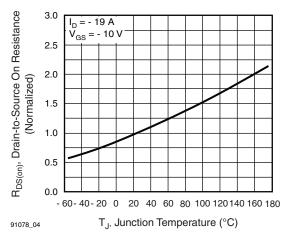


Fig. 4 - Normalized On-Resistance vs. Temperature



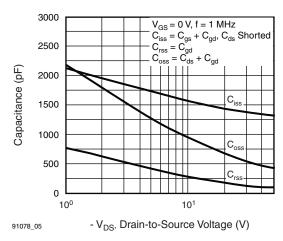


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

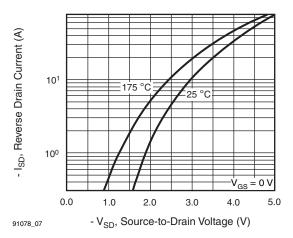


Fig. 7 - Typical Source-Drain Diode Forward Voltage

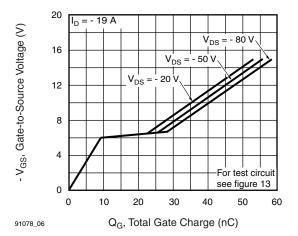


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

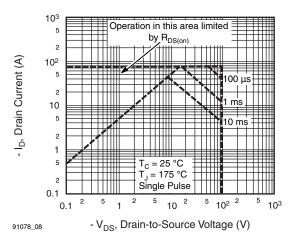


Fig. 8 - Maximum Safe Operating Area



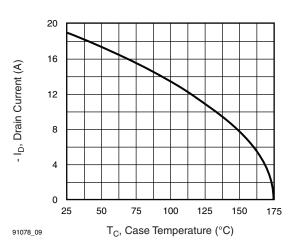


Fig. 9 - Maximum Drain Current vs. Case Temperature

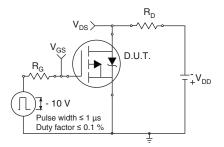


Fig. 10a - Switching Time Test Circuit

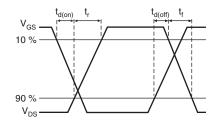


Fig. 10b - Switching Time Waveforms

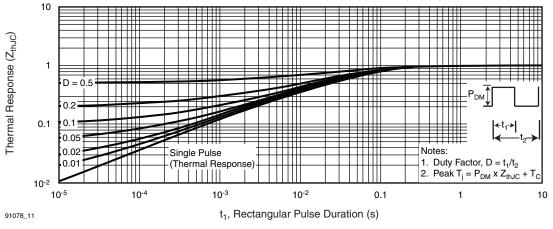


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



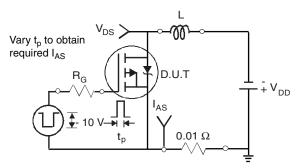


Fig. 12a - Unclamped Inductive Test Circuit

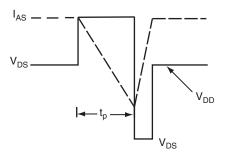


Fig. 12b - Unclamped Inductive Waveforms

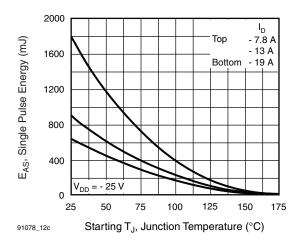


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

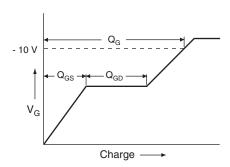


Fig. 13a - Basic Gate Charge Waveform

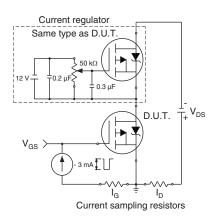
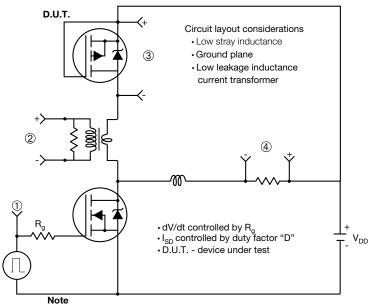


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



Compliment N-Channel of D.U.T. for driver

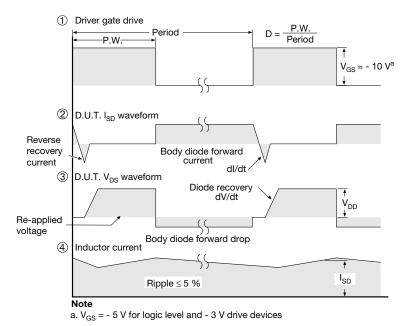


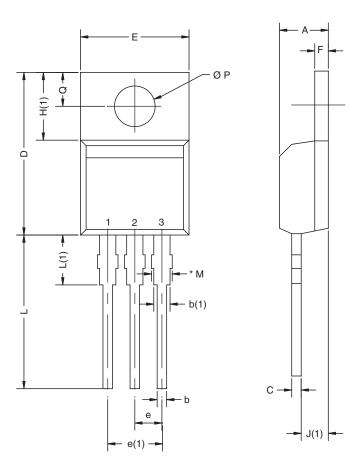
Fig. 14 - For P-Channel

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TO-220AB



	MILLIMETERS		INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØР	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	

DWG: 5471

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM

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